

**Search Notes****Application/Control No.**

10/708,835

**Examiner**

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**Applicant(s)/Patent under Reexamination**

BEENAU ET AL.

**Art Unit**

2635

**SEARCHED**

Class	Subclass	Date	Examiner
340	5.53	11/28/2005	NN
340	5.2	11/28/2005	NN
340	5.4+	11/28/2005	NN
340	5.52	11/28/2005	NN
340	5.6	11/28/2005	NN
340	5.8+	11/28/2005	NN
340	10.1	11/28/2005	NN
340	10.4-10.5	11/28/2005	NN
235	379	11/28/2005	NN
235	380	11/28/2005	NN
235	492	11/28/2005	NN
705	35,54,76	11/28/2005	NN
705	186,194	11/28/2005	NN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Search: USPAT; US-PUB; EPO;JPO and Derwent.	11/28/2005	NN